Notice of References Cited Application/Control No. 10/051,545 Examiner Wen-Tai Lin Applicant(s)/Patent Under Reexamination LU, YANFENG Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,430,624	08-2002	Jamtgaard et al.	709/246
*	В	US-2005/0027709	02-2005	White et al.	707/010
	O	US-			
	۵	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-	3 - 17		
	l	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	2					
	0					
	Р					
	α					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.